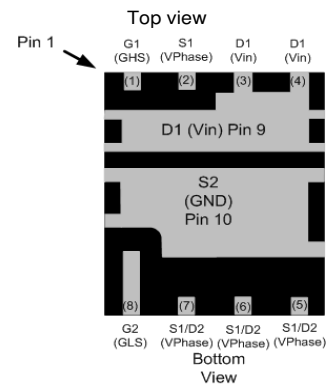
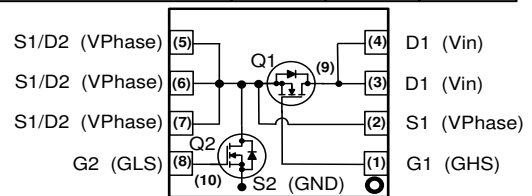


**Power Block**
**Features**

- Dual asymmetric N-channel OptiMOS™5 MOSFET
- Logic level (4.5V rated)
- Optimized for high performance buck converters
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

**Product Summary**

		Q1	Q2	
$V_{DS}$		25	25	V
$R_{DS(on),max}$	$V_{GS}=10\text{ V}$	3	0.8	mΩ
	$V_{GS}=4.5\text{ V}$	4	1.1	
$I_D$		50	50	A



Type	Package	Marking
BSG0811ND	PG-TISON8-4	0811ND

**Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified <sup>2)</sup>**

Parameter	Symbol	Conditions	Value		Unit
			Q1	Q2	
Continuous drain current	$I_D$	$T_C=70\text{ °C}, V_{GS}=10\text{ V}$	50	50	A
		$T_C=70\text{ °C}, V_{GS}=4.5\text{ V}$	50	50	
		$T_A=25\text{ °C}, V_{GS}=4.5\text{ V}^{3)}$	31	50	
		$T_A=25\text{ °C}, V_{GS}=4.5\text{ V}^{4)}$	19	41	
Pulsed drain current	$I_{D,pulse}$	$T_C=70\text{ °C}$	160	160	
Avalanche energy, single pulse	$E_{AS}$	Q1: $I_D=10\text{ A}$ , Q2: $I_D=20\text{ A}$ , $R_{GS}=25\text{ Ω}$	30	160	mJ
Gate source voltage	$V_{GS}$		±16		V
Power dissipation	$P_{tot}$	$T_A=25\text{ °C}^{3)}$	6.25	6.25	W
		$T_A=25\text{ °C}^{4)}$	2.5	2.5	
Operating and storage temperature	$T_j, T_{stg}$		-55 ... 150		°C
IEC climatic category; DIN IEC 68-1			55/150/56		

<sup>1)</sup> J-STD20 and JESD22

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Thermal characteristics**

Thermal resistance, junction - case	Q1	$R_{thJC}$		-	-	4.3	K/W
	Q2			-	-	1.8	
Thermal resistance, junction - ambient <sup>2)</sup>	Q1	$R_{thJA}$	application specific board <sup>3)</sup>	-	-	20	
	Q2						
	Q1	6 cm <sup>2</sup> cooling area <sup>4)</sup>	-	-	50		
	Q2						

**Electrical characteristics, at  $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified**
**Static characteristics**

Drain-source breakdown voltage	Q1	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=1\text{ mA}$	25 <sup>6)</sup>	-	-	V
	Q2						
Gate threshold voltage	Q1	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\text{ }\mu\text{A}$	1.2	1.6	2	
	Q2						
Zero gate voltage drain current	Q1	$I_{DSS}$	$V_{DS}=25\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$	-	-	1	$\mu\text{A}$
	Q2						
	Q1	$V_{DS}=25\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ }^\circ\text{C}$	-	-	100		
	Q2						
Gate-source leakage current	Q1	$I_{GSS}$	$V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$	-	-	100	nA
	Q2						
Drain-source on-state resistance	Q1	$R_{DS(on)}$	$V_{GS}=4.5\text{ V}, I_D=20\text{ A}$	-	3.2	4.0	m $\Omega$
	Q2						
	Q1	$V_{GS}=10\text{ V}, I_D=20\text{ A}$	-	2.4	3.0		
	Q2						
Gate resistance	Q1	$R_G$		-	0.7	1.2	$\Omega$
	Q2						
Transconductance	Q1	$g_{fs}$	$ V_{DS} >2 I_D R_{DS(on)max}, I_D=20\text{ A}$	46	93	-	S
	Q2						

<sup>2)</sup> Only one of both transistors active

<sup>3)</sup> 8 Layers copper 70 $\mu\text{m}$  thickness. PCB in still air.

<sup>4)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70  $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical in still air.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic characteristics**

Input capacitance	Q1	$C_{iss}$	$V_{GS}=0\text{ V},$ $V_{DS}=12\text{ V}, f=1\text{ MHz}$	-	780	1100	pF	
	Q2			-	2700	3700		
Output capacitance	Q1	$C_{oss}$		-	390	520		
	Q2			-	1400	1900		
Reverse transfer capacitance	Q1	$C_{rss}$		-	38	-		
	Q2			-	130	-		
Turn-on delay time	Q1	$t_{d(on)}$		$V_{IN}=12\text{ V},$ $V_{DRV}=5\text{ V},$ $F_{SW}=500\text{ KHz},$ $I_{OUT}=30\text{ A}^{5)}$	-	4.3	-	ns
	Q2				-	5.6	-	
Rise time	Q1	$t_r$			-	4.7	-	
	Q2				-	4.3	-	
Turn-off delay time	Q1	$t_{d(off)}$	-		4.3	-		
	Q2		-		8.8	-		
Fall time	Q1	$t_f$	-		1.4	-		
	Q2		-		2.6	-		

**Gate Charge Characteristics**

Gate to source charge	Q1	$Q_{gs}$	$V_{DD}=12\text{ V},$ $I_D=30\text{ A},$ $V_{GS}=0\text{ to }4.5\text{ V}$	-	2.0	-	nC		
Gate to drain charge		$Q_{gd}$		-	1.4	-			
Gate charge total		$Q_g$		-	5.6	8.4			
Gate plateau voltage		$V_{plateau}$		-	2.6	-	V		
Gate to source charge	Q2	$Q_{gs}$		$V_{DD}=12\text{ V},$ $I_D=30\text{ A},$ $V_{GS}=0\text{ to }4.5\text{ V}$	-	6.4	-	nC	
Gate to drain charge		$Q_{gd}$			-	4.7	-		
Gate charge total		$Q_g$			-	20	29		
Gate plateau voltage		$V_{plateau}$			-	2.3	-	V	
Output charge	Q1	$Q_{oss}$			$V_{DD}=12\text{ V}, V_{GS}=0\text{ V}$	-	8	-	nC
	Q2					-	27	-	

<sup>5)</sup> For more information see application note n° TBD

<sup>6)</sup> The device can withstand a pulse of not more than 30 V for a duration of up to 2 ns at a frequency of 600 kHz with maximum buck converter input voltage  $V_{IN}=16\text{ V}$ .

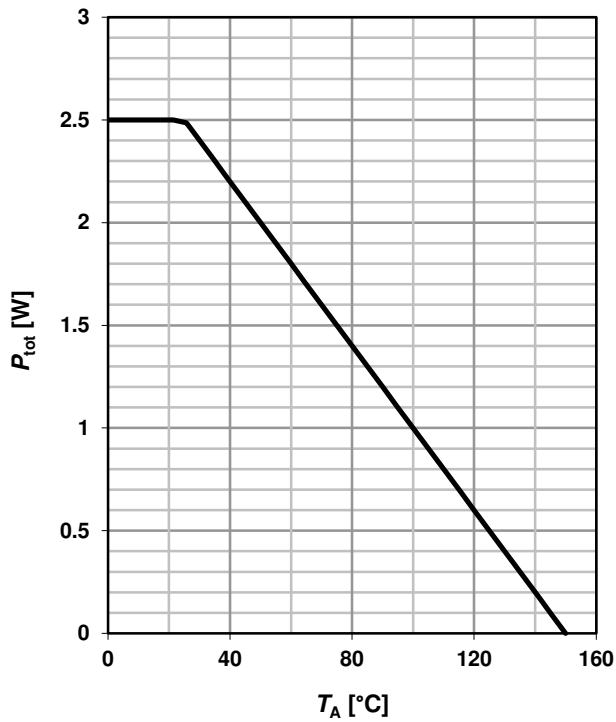
Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Reverse Diode**

Diode continuous forward current	Q1	$I_S$	$T_C=25\text{ °C}$	-	-	29	A
	Q2			-	-	50	
Diode pulse current	Q1	$I_{S,pulse}$		-	-	160	
	Q2			-	-	160	
Diode forward voltage	Q1	$V_{SD}$	$V_{GS}=0\text{ V}, I_F=20\text{ A},$ $T_j=25\text{ °C}$	-	0.84	1	V
	Q2			-	0.77	1	
Reverse recovery charge	Q1	$Q_{rr}$	$V_R=12\text{ V}, I_F=I_S,$ $di_F/dt=100\text{ A}/\mu\text{s}$	-	10	-	nC
	Q2			-	20	-	

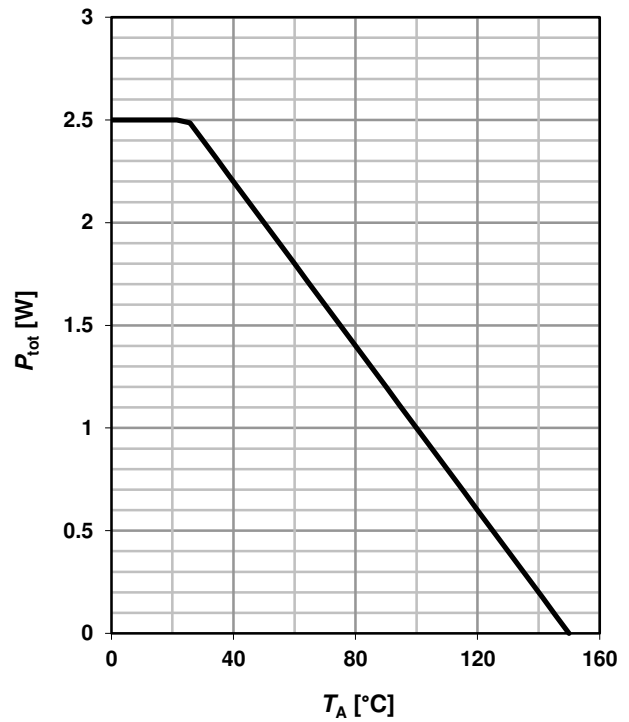
**1 Power dissipation (Q1)**

$$P_{\text{tot}} = f(T_A)^4$$



**2 Power dissipation (Q2)**

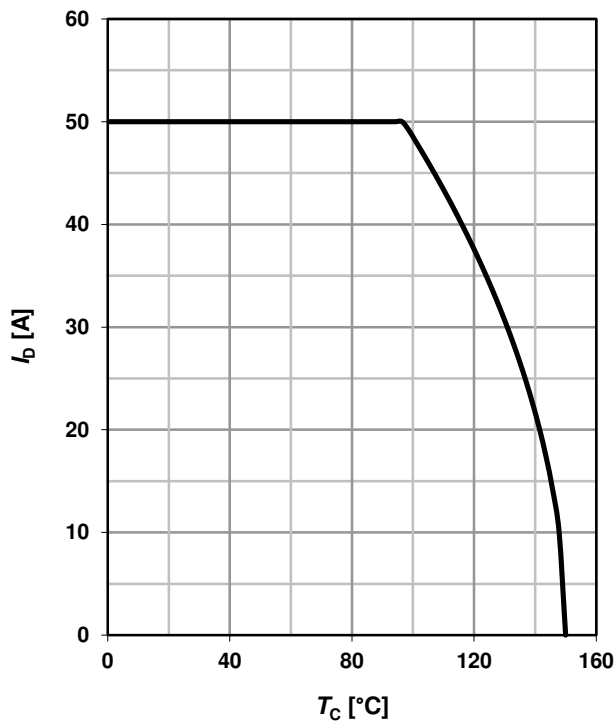
$$P_{\text{tot}} = f(T_A)^4$$



**3 Drain current (Q1)**

$$I_D = f(T_C)$$

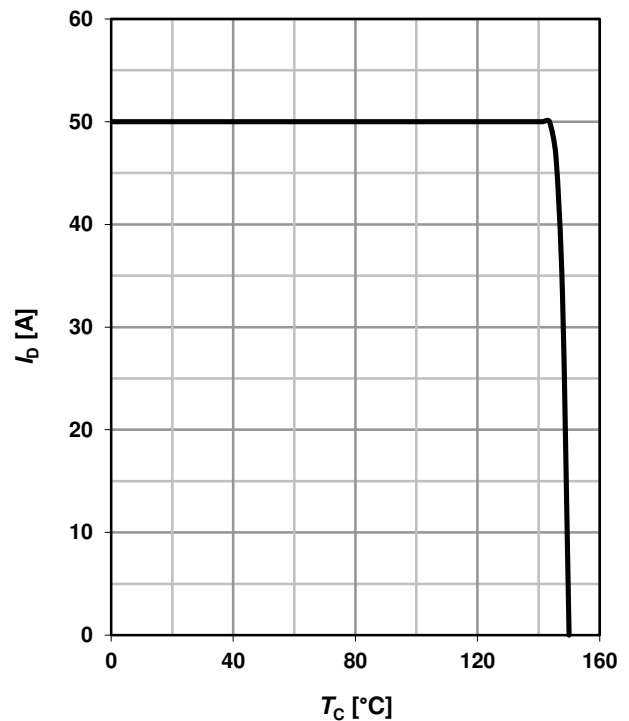
parameter:  $V_{GS} \geq 10$  V



**4 Drain current (Q2)**

$$I_D = f(T_C)$$

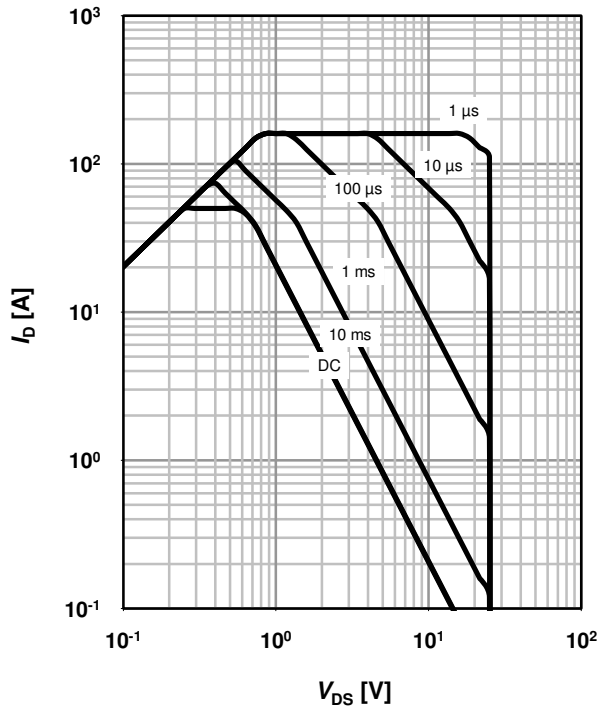
parameter:  $V_{GS} \geq 10$  V



**5 Safe operating area (Q1)**

$I_D=f(V_{DS}); T_C=25\text{ }^\circ\text{C}; D=0$

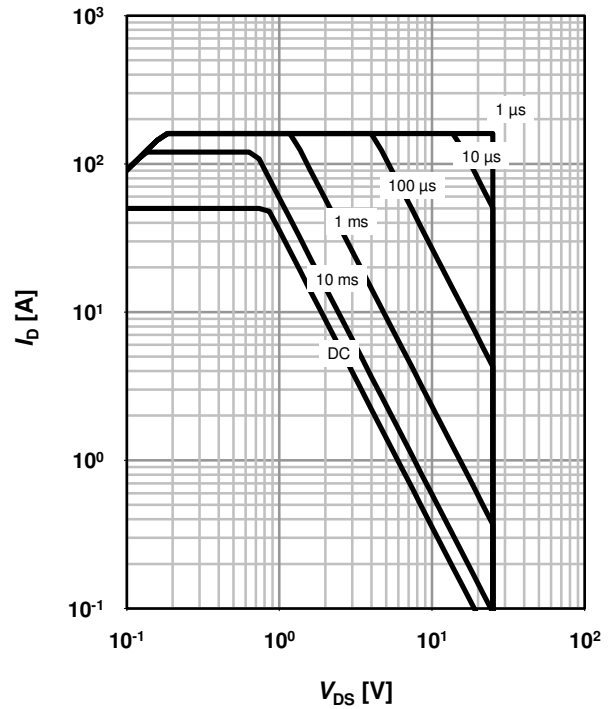
parameter:  $t_p$



**6 Safe operating area (Q2)**

$I_D=f(V_{DS}); T_C=25\text{ }^\circ\text{C}; D=0$

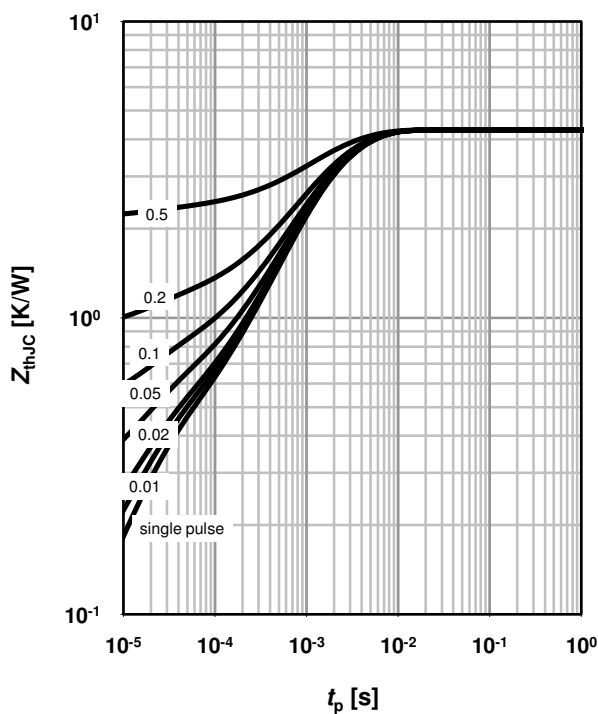
parameter:  $t_p$



**7 Max. transient thermal impedance (Q1)**

$Z_{thJC}=f(t_p)$

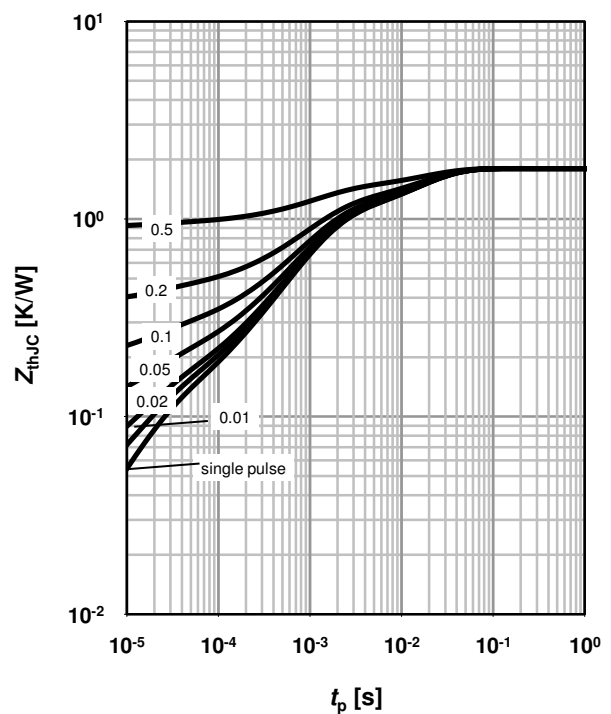
parameter:  $D=t_p/T$



**8 Max. transient thermal impedance (Q2)**

$Z_{thJC}=f(t_p)$

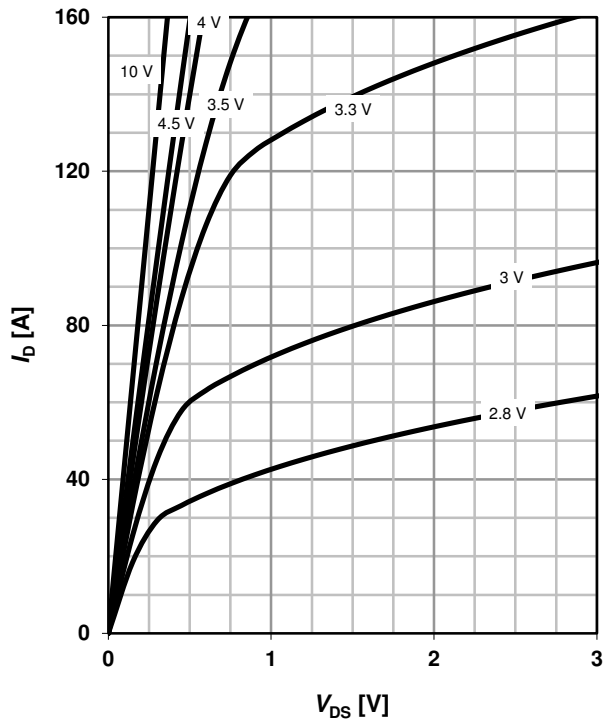
parameter:  $D=t_p/T$



**9 Typ. output characteristics (Q1)**

$I_D=f(V_{DS}); T_j=25\text{ }^\circ\text{C}$

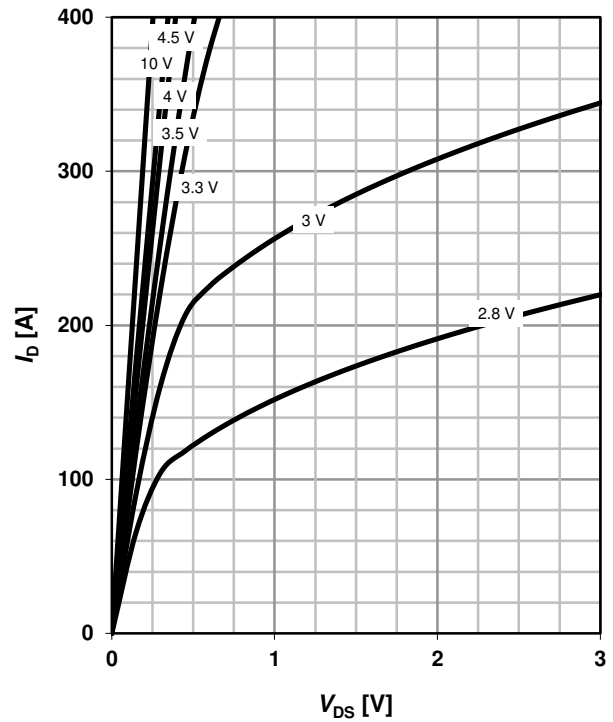
parameter:  $V_{GS}$



**10 Typ. output characteristics (Q2)**

$I_D=f(V_{DS}); T_j=25\text{ }^\circ\text{C}$

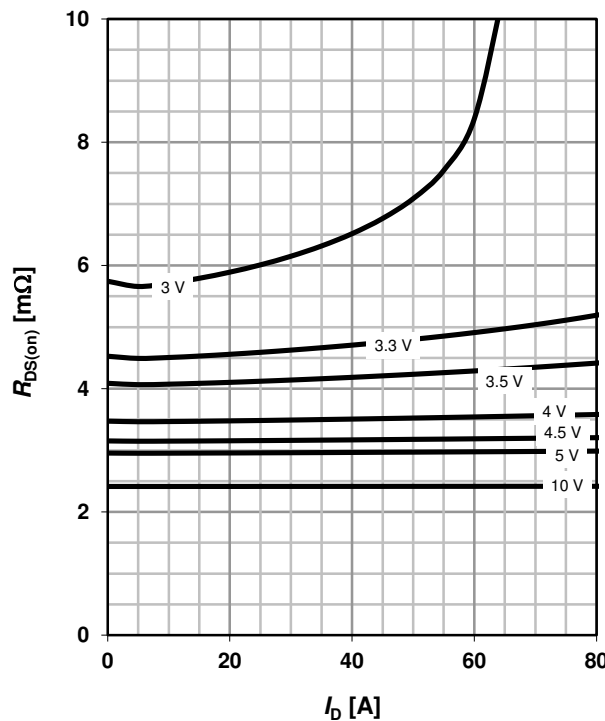
parameter:  $V_{GS}$



**11 Typ. drain-source on resistance (Q1)**

$R_{DS(on)}=f(I_D); T_j=25\text{ }^\circ\text{C}$

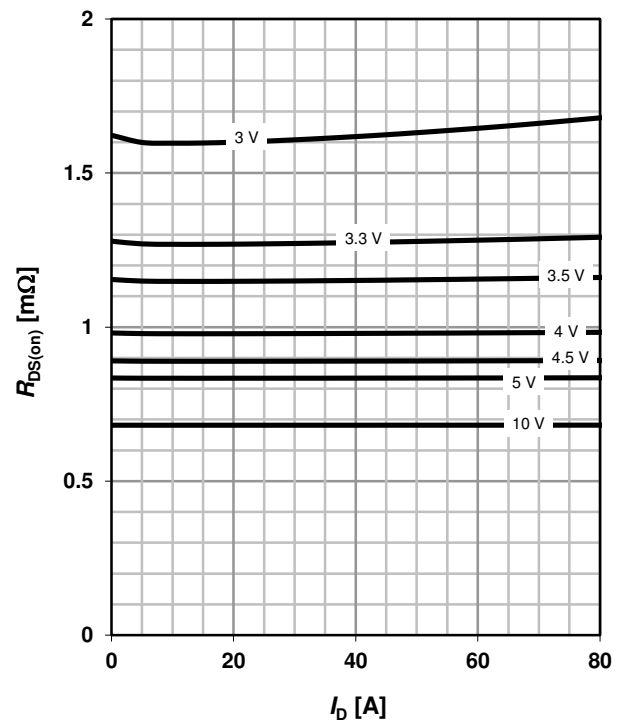
parameter:  $V_{GS}$



**12 Typ. drain-source on resistance (Q2)**

$R_{DS(on)}=f(I_D); T_j=25\text{ }^\circ\text{C}$

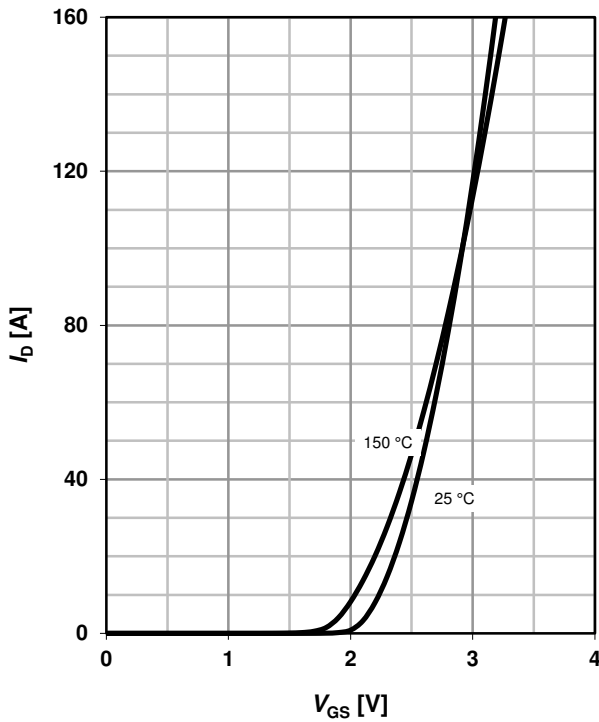
parameter:  $V_{GS}$



**13 Typ. transfer characteristics (Q1)**

$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

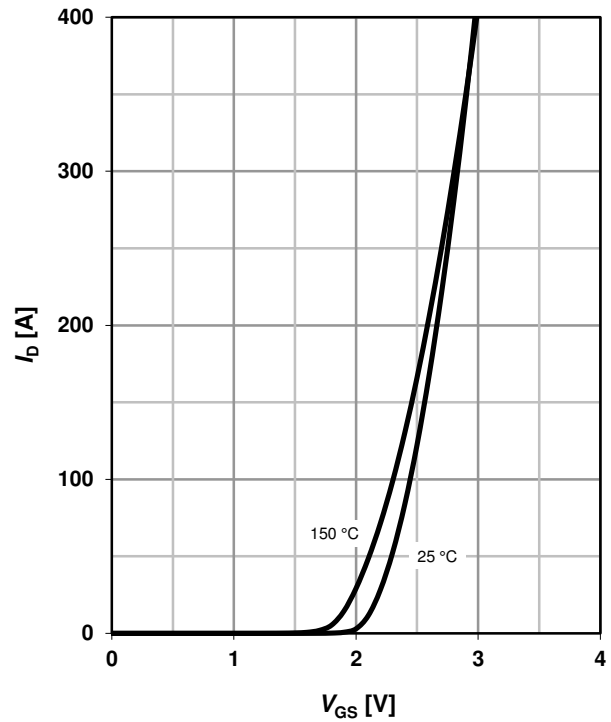
parameter:  $T_j$



**14 Typ. transfer characteristics (Q2)**

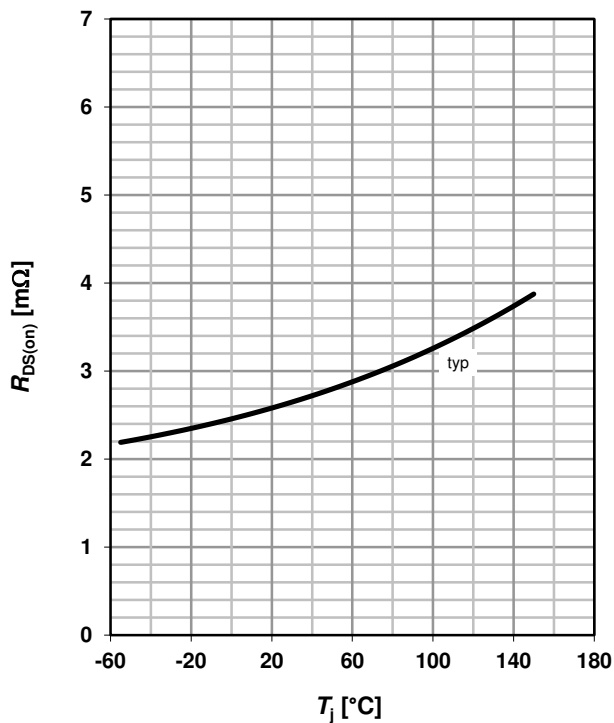
$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

parameter:  $T_j$



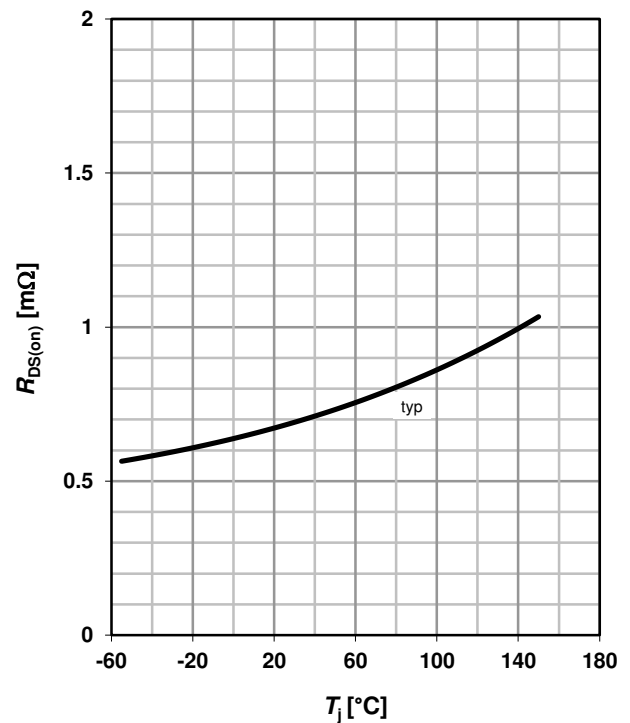
**15 Drain-source on-state resistance (Q1)**

$$R_{DS(on)} = f(T_j); I_D = 20 \text{ A}; V_{GS} = 10 \text{ V}$$



**16 Drain-source on-state resistance (Q2)**

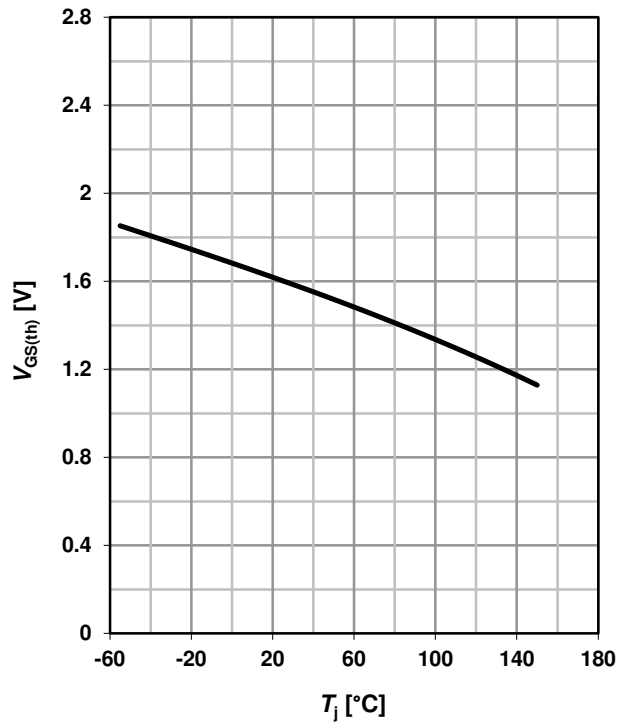
$$R_{DS(on)} = f(T_j); I_D = 20 \text{ A}; V_{GS} = 10 \text{ V}$$





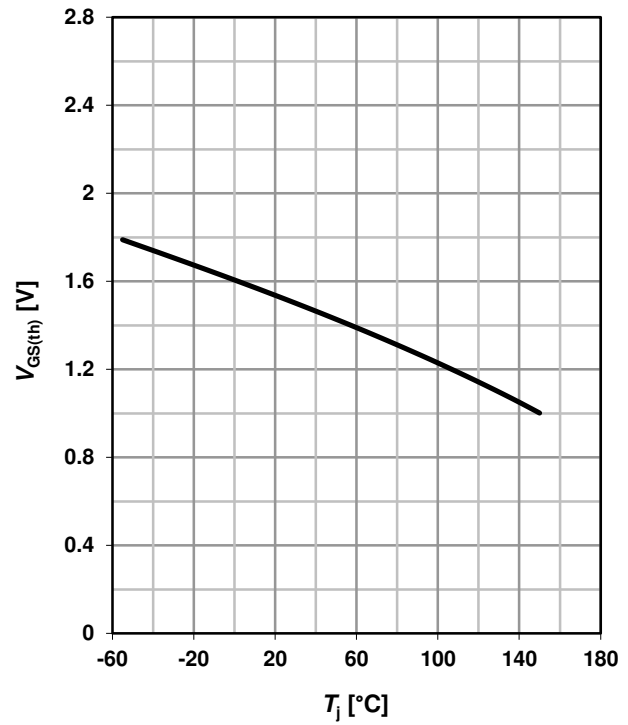
**17 Typ. gate threshold voltage (Q1)**

$V_{GS(th)}=f(T_j)$ ;  $V_{GS}=V_{DS}$ ;  $I_D=250 \mu A$



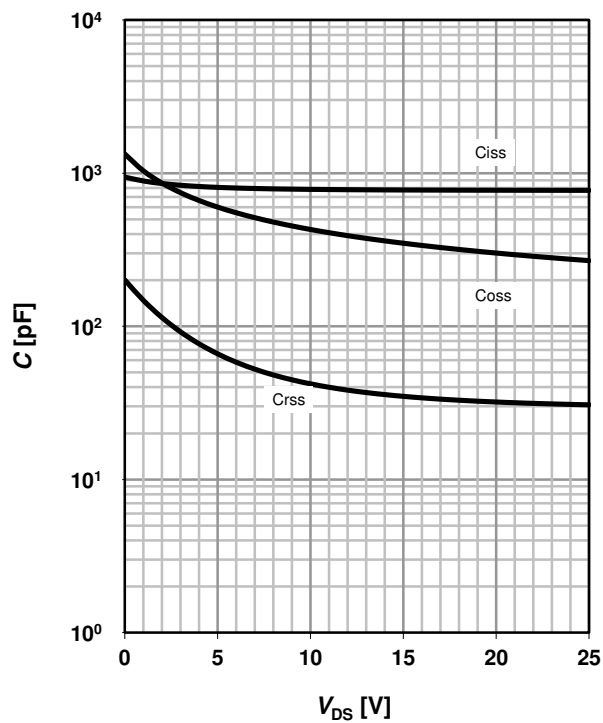
**18 Typ. gate threshold voltage (Q2)**

$V_{GS(th)}=f(T_j)$ ;  $V_{GS}=V_{DS}$ ;  $I_D=250 \mu A$



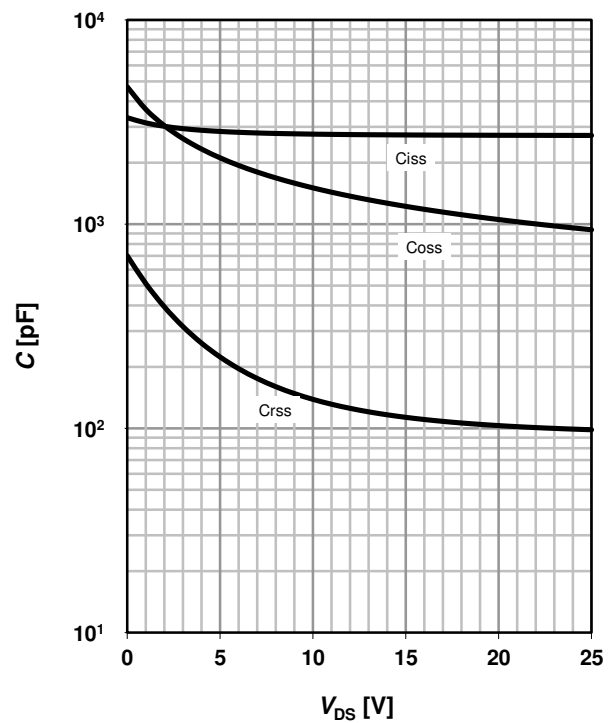
**19 Typ. capacitances (Q1)**

$C=f(V_{DS})$ ;  $V_{GS}=0 V$ ;  $f=1 MHz$



**20 Typ. capacitances (Q2)**

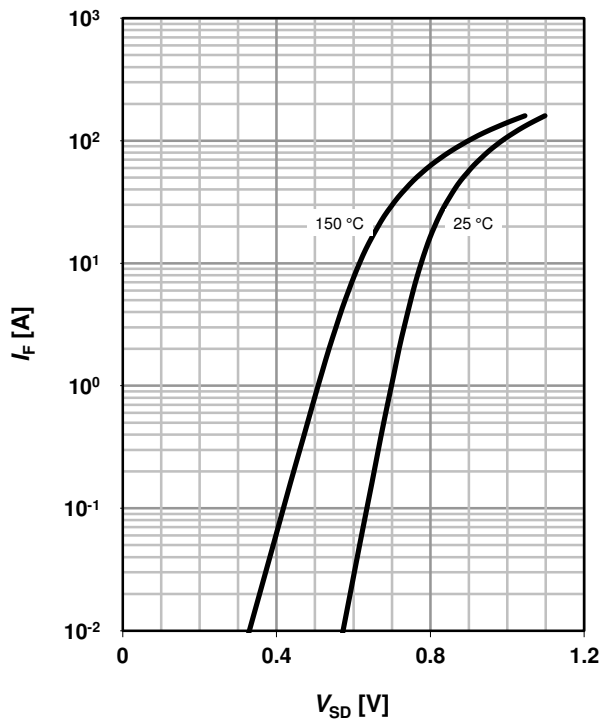
$C=f(V_{DS})$ ;  $V_{GS}=0 V$ ;  $f=1 MHz$



**21 Forward characteristics of reverse diode (Q1)**

$I_F=f(V_{SD})$

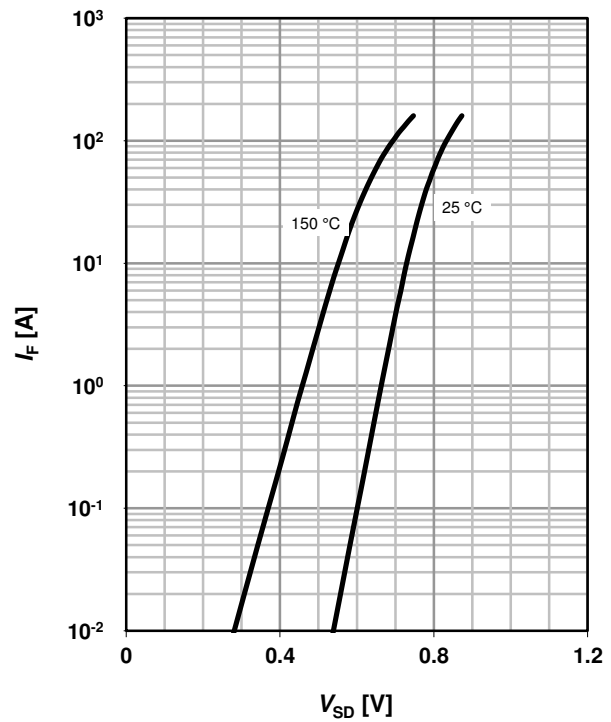
parameter:  $T_j$



**22 Forward characteristics of reverse diode (Q2)**

$I_F=f(V_{SD})$

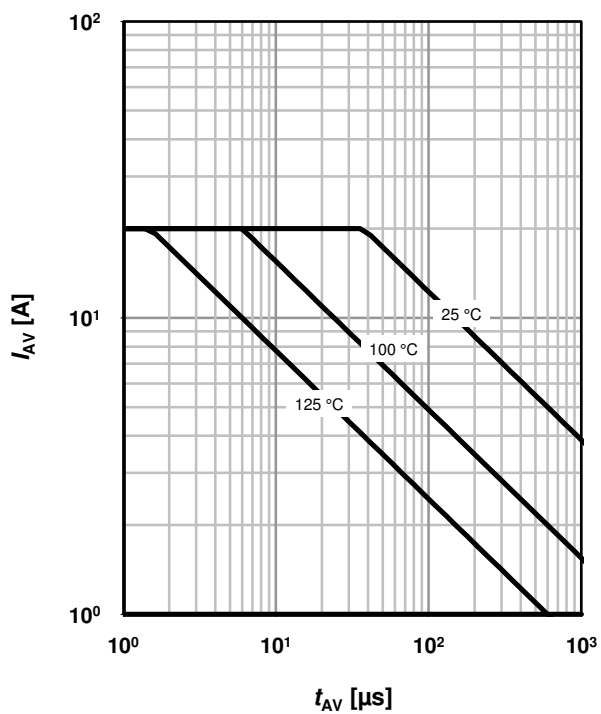
parameter:  $T_j$



**23 Avalanche characteristics (Q1)**

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

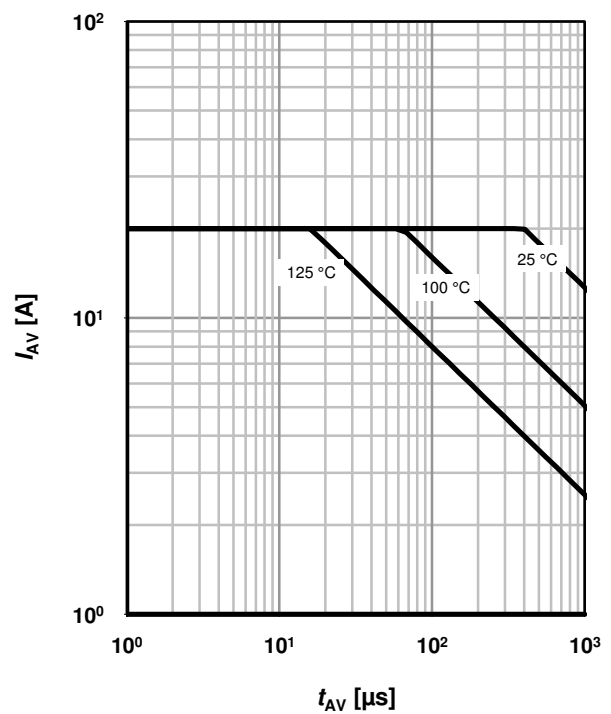
parameter:  $T_{j(start)}$



**24 Avalanche characteristics (Q2)**

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

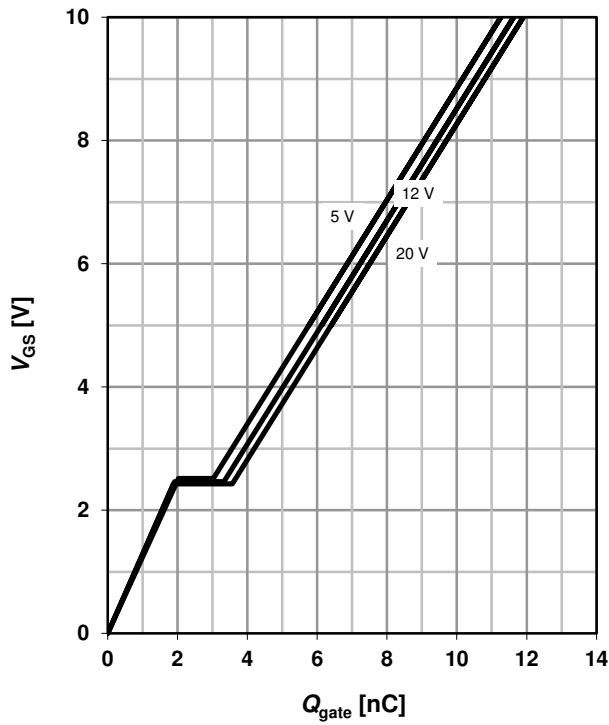
parameter:  $T_{j(start)}$



**25 Typ. gate charge (Q1)**

$V_{GS}=f(Q_{gate}); I_D=20\text{ A pulsed}$

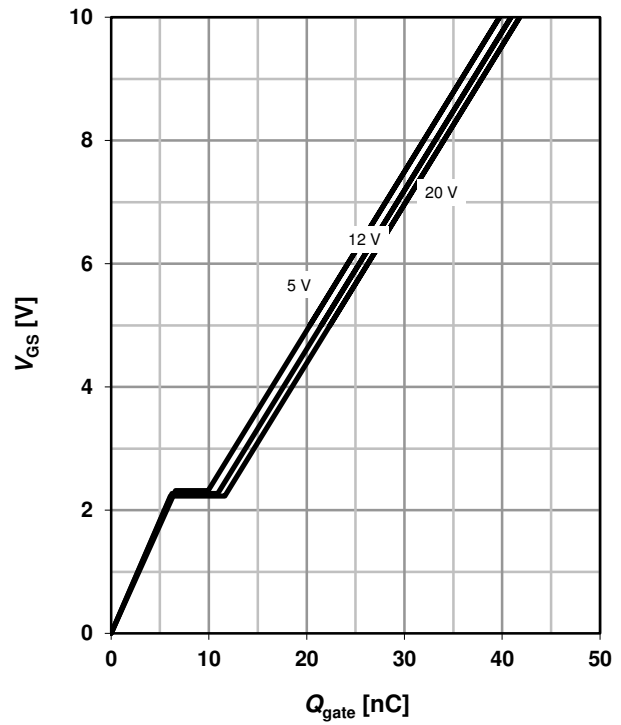
parameter:  $V_{DD}$



**26 Typ. gate charge (Q2)**

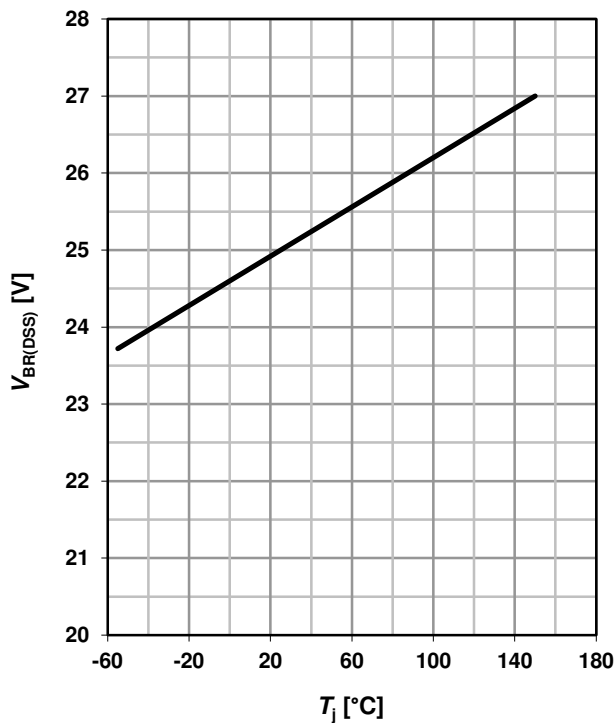
$V_{GS}=f(Q_{gate}); I_D=20\text{ A pulsed}$

parameter:  $V_{DD}$



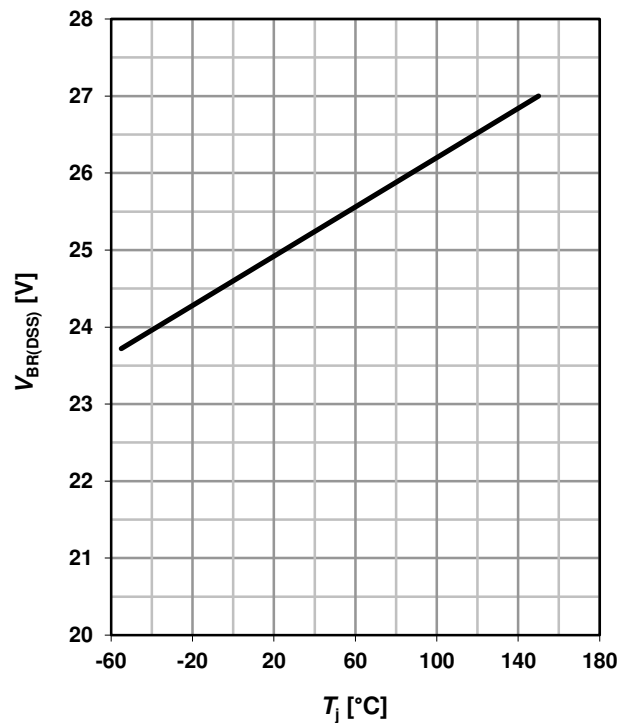
**27 Drain-source breakdown voltage (Q1)**

$V_{BR(DSS)}=f(T_j); I_D=1\text{ mA}$



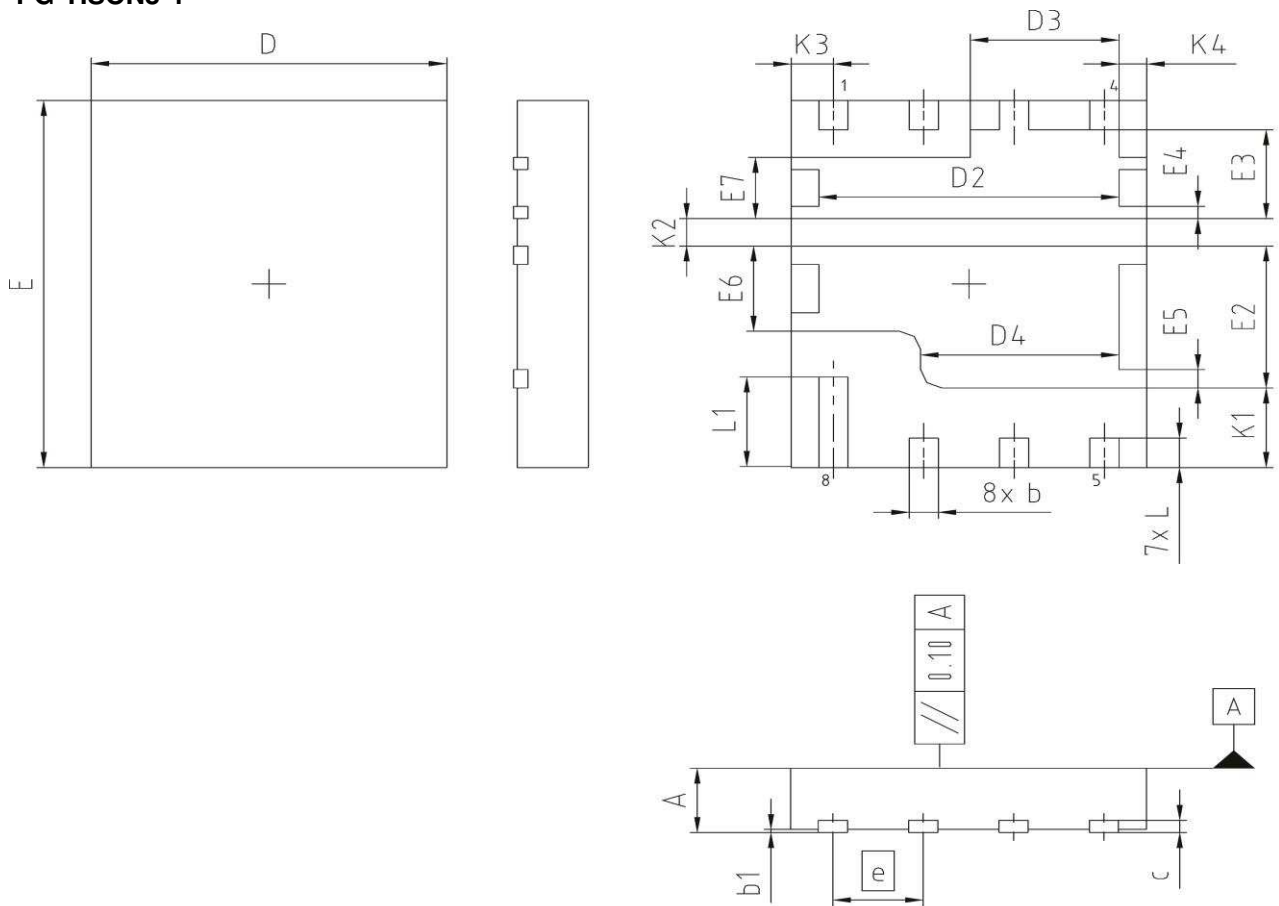
**28 Drain-source breakdown voltage (Q2)**

$V_{BR(DSS)}=f(T_j); I_D=1\text{ mA}$



Package Outline

PG-TISON8-4



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.90	1.15	0.035	0.045
b	0.31	0.51	0.012	0.020
b1	0.00	0.05	0.000	0.002
c	0.10	0.30	0.004	0.012
D	4.90	5.10	0.193	0.201
D2	4.12	4.32	0.162	0.170
D3	1.99	2.19	0.078	0.086
D4	2.69	2.89	0.106	0.114
E	5.90	6.10	0.232	0.240
E2	2.22	2.42	0.087	0.095
E3	1.35	1.55	0.053	0.061
E4	0.10	0.30	0.004	0.012
E5	0.20	0.40	0.008	0.016
E6	1.29	1.49	0.051	0.059
E7	0.90	1.10	0.035	0.043
e	1.27 (BSC)		0.05 (BSC)	
N	8		8	
L	0.38	0.58	0.015	0.023
L1	1.38	1.58	0.054	0.062
K1	1.38	1.58	0.054	0.062
K2	0.35	0.55	0.014	0.022
K3	0.50	0.70	0.020	0.028
K4	0.29	0.49	0.011	0.019

DOCUMENT NO.  
Z8B00176527

SCALE

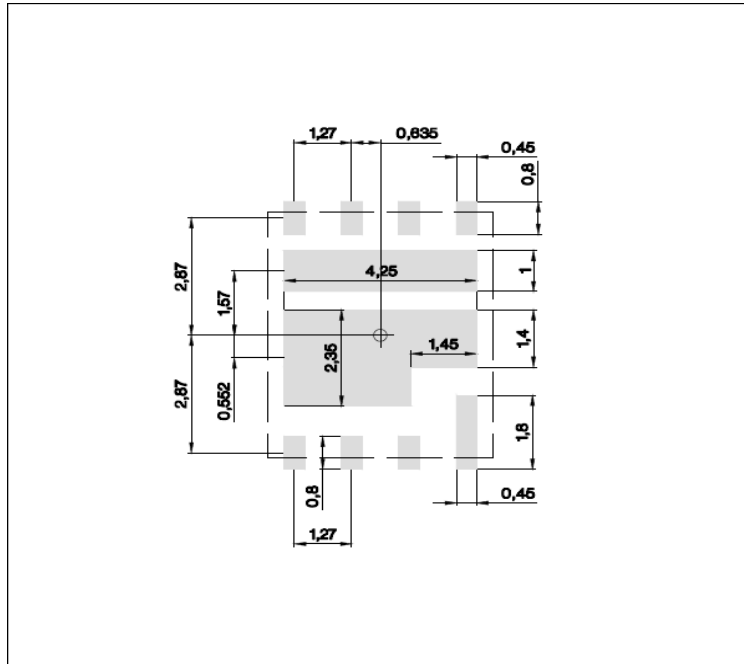
EUROPEAN PROJECTION

ISSUE DATE  
09-08-2017

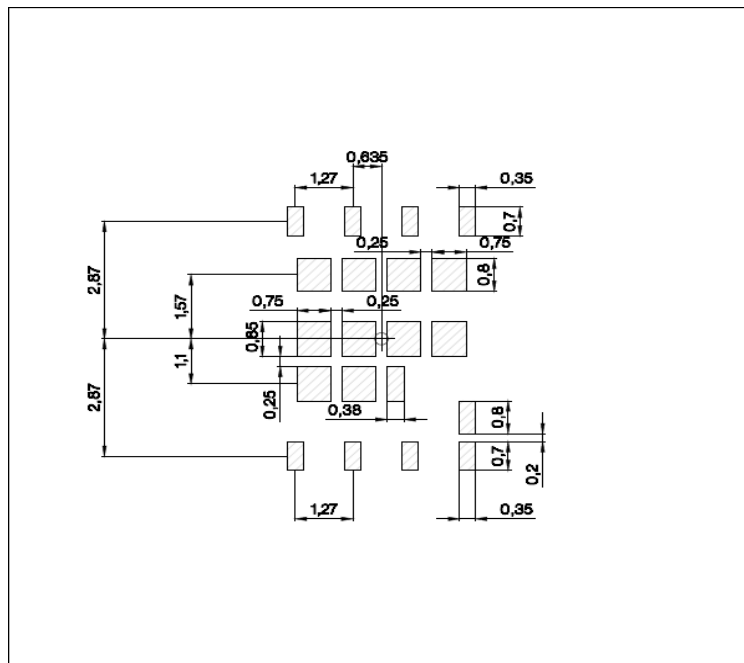
REVISION  
02

Boardpads & Apertures

PG-TISON8-4



■ copper



▨ stencil apertures

All the dimensions in mm

## Revision History

BSG0811ND

**Revision: 2017-08-25, Rev. 2.2**

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2015-03-17	Release of final version
2.1	2016-03-24	Update package drawing
2.2	2017-08-25	Update package outline

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